TIL111, TIL114, TIL116, TIL117 **OPTOCOUPLERS**

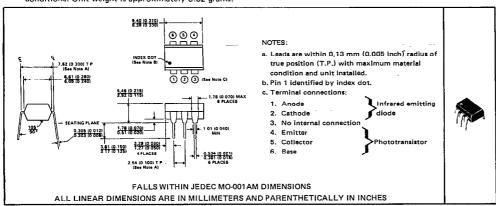
D1607, NOVEMBER 1973-REVISED FEBRUARY 1983

COMPATIBLE WITH STANDARD TTL INTEGRATED CIRCUITS

- Gallium Arsenide Diode Infrared Source Optically Coupled to a Silicon N-P-N Phototransistor
- High Direct-Current Transfer Ratio
- High-Voltage Electrical Isolation . . . 1.5-kV or 2.5-kV Rating
- Plastic Dual-In-Line Package
- High-Speed Switching: $t_r = 5 \mu s$, $t_f = 5 \mu s$ Typical

mechanical data

The package consists of a gallium arsenide infrared-emitting diode and an n·p·n silicon phototransistor mounted on a 6-lead frame encapsulated within an electrically nonconductive plastic compound. The case will withstand soldering temperature with no deformation and device performance characteristics remain stable when operated in high-humidity conditions. Unit weight is approximately 0.52 grams.



absolute maximum ratings at 25°C free-air temperature (unless otherwise noted)

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Input-to-Output Voltage: TIL111
TIL114, TIL116, TIL117
Collector-Base Voltage
Collector-Emitter Voltage (See Note 1)
Emitter-Collector Voltage
Emitter-Base Voltage
Input-Diode Reverse Voltage
Input-Diode Continuous Forward Current at (or below) 25°C Free-Air Temperature (See Note 2) 100 mA
Continuous Power Dissipation at (or below) 25°C Free Air Temperature:
Infrared-Emitting Diode (See Note 3)
Phototransistor (See Note 4)
Total, Infrared-Emitting Diode plus Phototransistor (See Note 5)
Storage Temperature Range
Lead Temperature 1,6 mm (1/16 Inch) from Case for 10 Seconds
OTES: 1. This value applies when the base-emitter diode is open-circulted.

NO

- This value applies when the base-entitle dood is open-circular to the control of th
- PRODUCTION DATA documents contain information current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.



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Optocouplers (Isolators)

electrical characteristics at 25°C free-air temperature

	PARAME	METER TEST CONDITIONS		TIL111 TIL114			TIL116			7	UNIT			
					MIN TYP MAX		MIN	TYP	MAX	MIN TYP MAX			1	
V(BR)CBO	Collector-Base Breakdown Voltage		IC = 10 μA, IF = 0	IE = 0,	70			70			70			V
V(BR)CEO	Collector-Emitter Breakdown Voltage		I _C = 1 mA, I _F = 0	i _B = 0,	30			30			30			v
V(BR)EBO	Emitter-Base Breakdown Voltage		l _E = 10 μA, l _F = 0	IC = 0,	7			7			7			V
¹R	Input Diode Static Reverse Current		V _R = 3 V				10			10			10	μА
IC(on)	On-State Collector Current	Phototransistor Operation		-	2	7								mA
			V _{CE} = 10 V, I _B = 0	•				2	5		5	9		""
		Photodiode Operation	V _{CB} = 0.4 V, I _E = 0		7	20		7	20		7	20		μА
^I C(off)	Off-State Collector Current	Phototransistor Operation	V _{CE} = 10 V, I _B = 0			1	50		1	50		1	50	nA
		Photodiode Operation	V _{CB} = 10 V, I _E = 0	·		0.1	20		0.1	20		0.1	20	
hFE	Transistor Static Forward Current Transfer Ratio		V _{CE} = 5 V, I _F = 0	IC = 10 mA,	100	300					200	550		
"FE			V _{CE} = 5 V, i _F = 0	I _C = 100 μA,				100	300					
٧ _F	Input Diode Static Forward Voltage		lr = 16 mA			1.2	1.4					1.2	1.4	v
<u>-</u>	Forward \	/ OI tage	I _F = 60 mA I _C = 2 mA, I _B = 0	l _F = 16 mA,		0.25	0.4		1.25	1.5				
VCE (sat)	Collector-Emitter Saturation Voltage		1 _C = 2.2 mA, 1 _B = 0						0.25	0.4				v
			I _C = 0.5 mA,									0.25	0.4	
rio .	Input-to-Output Internal Resistance			kV for TIL111, kV for all others,	1011			1011			1011			Ω
c _{io}	Input-to-Output Capacitance		V _{in-out} = 0, See Note 6	f = 1 MHz,		1	1,3		1	1.3		1	1.3	рF

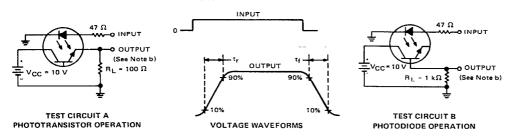
NOTE 6: These parameters are measured between both input-diode leads shorted together and all the phototransistor leads shorted togethe

switching characteristics at 25°C free-air temperature

PARAMETER			TEST CONDITIONS		TIL111 TIL114			TIL116			TIL117		
					TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	1
t _r	Rise Time	Phototransistor		,	5	10		5	10		5	10	
t _f	Fall Time	Operation	R _L = 100 Ω, See Test Circuit A of Figure 1		5	10		5	10		5	10	μς
t _r	Rise Time	Photodiode	V _{CC} = 10 V, I _{C(on)} = 20 μΑ		1			1			1		
tf	Fall Time	Operation	R _L = 1 kΩ, See Test Circuit B of Figure 1		1			1			1		μ\$

PARAMETER MEASUREMENT INFORMATION

Adjust amplitude of input pulse for: $I_{C(on)} = 2 \text{ mA (Test Circuit A) or}$ $I_{C(on)} = 20 \mu \text{A (Test Circuit B)}$

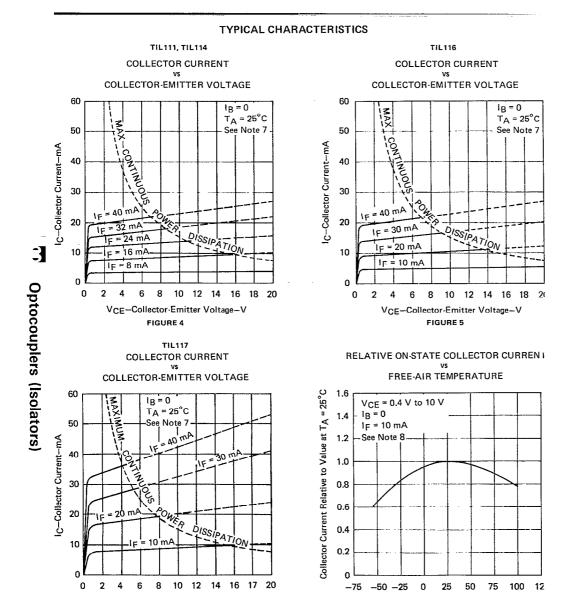


NOTES: a. The input waveform is supplied by a generator with the following characteristics: $Z_{out} = 50 \Omega_{c} t_{p} \le 15 \text{ ns, duty cycle} \approx 1\%$, t_W = 100 μ s. b. The output waveform is monitored on an oscilloscope with the following characteristics: $t_r \le 12$ ns, $R_{in} \ge 1$ M Ω , $C_{in} \le 20$ pF.

FIGURE 1-SWITCHING TIMES

TYPICAL CHARACTERISTICS TIL111, TIL114 TIL116, TIL117 **COLLECTOR CURRENT** COLLECTOR CURRENT INPUT-DIODE FORWARD CURRENT INPUT-DIODE FORWARD CURRENT 100 100 V_{CE} = 0.4 V V_{CE} = 10 V 40 40 $I_B \simeq 0$ IB = 0 = 25°C TA = 25°C 10 IC-Collector Current-mA IC-Collector Current-mA 10 TIL116 1 0.4 0.4 0.1 0.1 0.04 0.04 0.01 0.01 0.1 4 10 40 0.1 0.4 1 4 10 40 100 IF-Forward Current-mA IF-Forward Current-mA FIGURE 2 FIGURE 3





NOTES: 7. Pulse operation of input diode is required for operation beyond limits shown by dotted lines. 8. These parameters were measured using pulse techniques. $t_W = 1$ ms, duty cycle $\leq 2\%$.

VCE-Collector-Emitter Voltage-V

FIGURE 6



T_A-Free-Air Temperature-°C

FIGURE 7

= 475 Ω

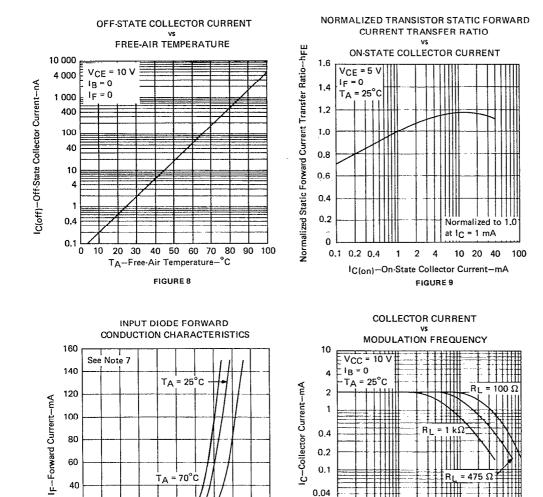
400 1000

40 100

 $f_{\mbox{mod}}-\mbox{Modulation Frequency}-\mbox{kHz}$

FIGURE 11

TYPICAL CHARACTERISTICS



NOTE 7: These parameters were measured using pulse techniques, t_W = 1 ms, duty cycle < 2%

T_A = 70°C

0.2 0.4 0.6 0.8 1.0 1.2 1.4 1.6 1.8 2.0

VF-Forward Voltage-V

FIGURE 10

40

20

0

0



–55°C

0.1

0.04

0.02

0.01

1

4 10